Application/Control No. Applicant(s)/Patent Under Reexamination 10/670,269 HSIEH, YOU-JUN Notice of References Cited Examiner Art Unit Page 1 of 1 2629 Jean E. Lesperance **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,525,743 B1 02-2003 Patrick et al. Α 345/619 US-В US-С US-D US-Е US-F US-G US-Н US-US-J US-Κ US-L US-M **FOREIGN PATENT DOCUMENTS** Document Number Date Country Country Code-Number-Kind Code Name Classification MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W

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